

### **General Features**

- Split gate trench MOSFET technology
- Low RDS(on) & FOM
- Extremely low switching loss
- Excellent stability and uniformity

## Application

- Power management
- Portable equipment



TO-252



VDS	-100	V
R DS(on),Typ@ VGS=10 V	75	mΩ
/ D	-20	А



P-channel

#### Absolute Maximum Ratings (T<sub>A</sub>=25°C unless otherwise noted)

Parameter		Symbol	Limit	Unit	
Drain-source Voltage		V <sub>DS</sub>	-100	V	
Gate-source Voltage		V <sub>GS</sub>	±20	V	
Drain Current	Tc=25℃		-20	A	
	Tc=100℃	ID	-14		
Pulsed Drain Current <sup>A</sup>		I <sub>DM</sub>	-80	A	
Avalanche energy <sup>B</sup>		Eas	100	mJ	
Total Power Dissipation	<b>Tc=25</b> ℃	72		10/	
	Tc=100℃	۳D	28.8	vv	
Junction and Storage Temperature Range		T <sub>J</sub> ,T <sub>STG</sub>	-55~+150	Ĉ	

#### Thermal resistance

Parameter	Symbol	Тур	Мах	Units	
Thermal Resistance Junction-to-Ambient D	t≪10S	P	15	20	°C <b>W</b>
Thermal Resistance Junction-to-Ambient <sup>D</sup>	Steady-State	K8JA	40	50	
Thermal Resistance Junction-to-Case	Steady-State	R <sub>ejc</sub>	1.35	1.7	



ASDM100R750PKQ

-100V P-Channel MOSFET

#### Electrical Characteristics (TJ=25°C unless otherwise noted)

Parameter	Symbol	Conditions		Min	Тур	Max	Units
Static Parameter							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> =-250μA		-100			V
	I <sub>DSS</sub>	V <sub>DS</sub> =-100V,V <sub>GS</sub> =0V	<b>T</b> j <b>=25</b> ℃			-1	μΑ
Zero Gate Voltage Drain Current			Tj <b>=55</b> ℃			-5	
			<b>T</b> j <b>=125</b> ℃			-10	
Gate-Body Leakage Current	I <sub>GSS</sub>	$V_{GS}$ = $\pm 20^{\circ}$	V, V <sub>DS</sub> =0V			±100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , I	<sub>D</sub> =-250µA	-1.0	-1.8	-2.5	V
Statia Drain Source On Pagistance	D	V <sub>GS</sub> = -10V, I <sub>D</sub> =-10A			75	95	
Static Diain-Source On-Resistance	RDS(ON)	V <sub>GS</sub> = -4.5	/, I <sub>D</sub> =-5A		85	110	mΩ
Diode Forward Voltage	$V_{\text{SD}}$	I <sub>S</sub> =-10A,	V <sub>GS</sub> =0V			-1.3	V
Maximum Body-Diode Continuous Current	I <sub>S</sub>					-20	А
Dynamic Parameters							
Input Capacitance	$C_{iss}$	V <sub>DS</sub> =-50V,V <sub>GS</sub> =0V,f=1MHZ			1051		
Output Capacitance	C <sub>oss</sub>				119		pF
Reverse Transfer Capacitance	C <sub>rss</sub>				25		
Switching Parameters							
Total Gate Charge	Q <sub>g</sub> (-10V)	- - V <sub>GS</sub> =-10V,V <sub>DS</sub> =-50V,I <sub>D</sub> =-5A			20.1		
Total Gate Charge	Q <sub>g</sub> (-4.5V)				9.7		
Gate-Source Charge	$Q_gs$				3.9		nC
Gate-Drain Charge	$Q_{gd}$				4.3		
Reverse Recovery Chrage	Q <sub>rr</sub>	− I <sub>F</sub> =-5A, di/dt=100A/us			140		
Reverse Recovery Time	t <sub>rr</sub>				70		
Turn-on Delay Time	t <sub>D(on)</sub>	V <sub>GS</sub> =-10V,V <sub>DD</sub> =-50V,R <sub>L</sub> =2.5Ω R <sub>GEN</sub> =6Ω			10		
Turn-on Rise Time	tr				30		ns
Turn-off Delay Time	t <sub>D(off)</sub>				77		
Turn-off fall Time	t <sub>f</sub>				81		

A. Repetitive rating; pulse width limited by max. junction temperature.

B.  $V_{DD}$ =50V, R<sub>G</sub>=25 $\Omega$ , L=0.5mH.

C. Pd is based on max. junction temperature, using junction-case thermal resistance.

D. The value of RθJA is measured with the device mounted on 1in2 FR-4 board with 2oz. Copper, in a still air environment with TA =25° C. The Power dissipation PDSM is based on RθJA t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.



# **Typical Performance Characteristics**



Figure 1. Output Characteristics



Figure3. Capacitance Characteristics



Figure5. : On-Resistance vs. Gate to Source Voltage



Figure2. Transfer Characteristics



Figure 4. Gate Charge



Figure6.Normalized On-Resistance



ASDM100R750PKQ -100V P-Channel MOSFET



Figure7. Drain current

Figure8.Safe Operation Area



Figure9.Normalized Maximum Transient thermal impedance



# **Ordering and Marking Information**

Ordering Device No.	Marking	Package	Packing	Quantity
ASDM100R750PKQ-R	100R750P	TO-252	Tape&Reel	2500/Reel





ASDM100R750PKQ -100V P-Channel MOSFET

**TO-252** 





#### IMPORTANT NOTICE

ShenZhen Ascend Semiconductor incorporated MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

ShenZhen Ascend Semiconductor Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. ShenZhen Ascend Semiconductor Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does ShenZhen Ascend Semiconductor Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume.

all risks of such use and will agree to hold Ascendsemi Incorporated and all the companies whose products are represented on ShenZhen Ascend Semiconductor Incorporated website, harmless against all damages.

ShenZhen Ascend Semiconductor Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel. Should Customers purchase or use ShenZhen Ascend Semiconductor Incorporated products for any unintended or unauthorized application, Customers shall indemnify and hold ShenZhen Ascend Semiconductor Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

www.ascendsemi.com